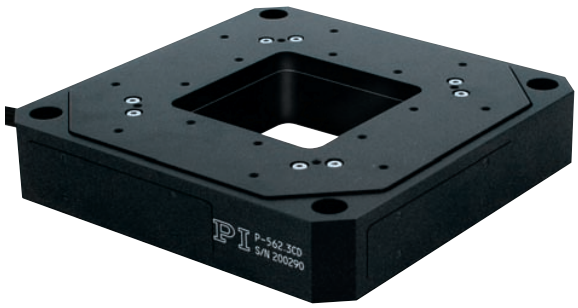
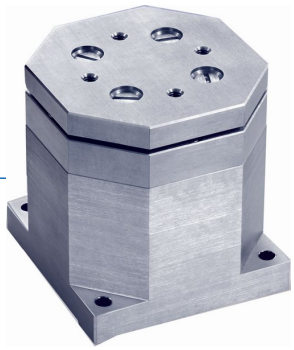
XYZ Piezo Positioning Flexure Stages

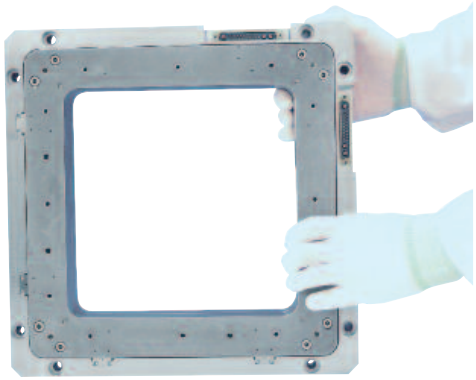
Nanometer and Picometer Resolution, High Speed & Stability

FAST



PRECISE





INDIVIDUAL

Click on the Images to Jump to Datasheet

XYZ / XY Piezo Stage Systems

PInano™ microscope scanner stage for Super Resolution-microscopy applications. Sub-nanometer resolution Optional slide holder & accessories for microscopes.

P-562 PIMars™ multi-axis, parallel-kinematics piezo nanopositioning stage. Travel to 340 µm/axis. Capacitive parallel metrology.

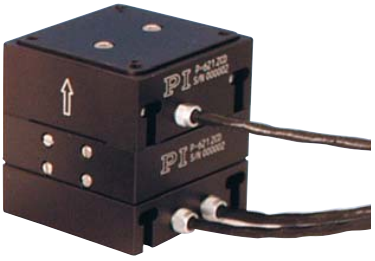
P-363 PicoCube™ multi-axis planar scanner. For AFM/STM and nanomanipulation applications. Picometer resolution.

P-611 NanoCube® low-cost XYZ-nanopositioning system, 100µm open-loop and closed-loop versions.

P-615 Long-Travel NanoCube® XYZ nanopositioning stage with aperture. Up to 420µm travel, capacitive feedback

P -733 piezo scanning stages provide travel to 100µm / axis. Very high accuracy and fast response, ideal for STED microscopy

P-915KLVS large aperture, high-dynamics piezo scanner



PIHera® XYZ combination.

P-313 PicoCube™ XY(Z) Piezo Scanner

Picometer Precision, High Bandwidth, No Servo Lag, for Scanning Probe Microscopy

A new drive concept allows high-linearity positioning in open-loop operation

- **Ultra-High-Performance Scanner for AFM/SPM**
- **20 Picometers Resolution, <1 nm Hysteresis**
- **Very High Bandwidth with no Servo Lag Due to New Drive Concept**
- **Compact Manipulation Tool for Bio-/Nanotechnology**
- **Resonant Frequency 4.0 kHz (X, Y), 11 kHz (Z)**
- **1 x 1 x 0.8 µm Travel Range**

Model	Travel range (±250 V)	Resolution	Dimensions
P-313.30 PicoCube™ XYZ Scanner	1 x 1 µm (X,Y) 0.8 µm (Z)	0.02 nm (X, Y) 0.14 nm (Z)	30 x 30 x 29.4 mm Moved platform 20 x 20 mm

P-545 PI nano™ XYZ / PI nano™ XY Piezo Stage Systems

Low-Profile, Low-Cost Nanopositioning Systems for Super-Resolution Microscopy

PI nano™ series nanopositioning stages feature a very low profile of 20 mm (0.8), a large aperture for 3 x 1'' slides and deliver highly accurate motion with sub-nanometer resolution in up to 3 axes. Slide / petri dish holders optional

- **Low Profile for Easy Integration: 20 mm (0.8")**
- **Up to 200 x 200 x 200 µm Travel Ranges**
- **Large Clear Aperture for 3 x 1" Slides**
- **Recessed Sample Holders for Maximized Utility Available**
- **Outstanding Lifetime Due to PICMA®Piezo Actuators**
- **Cost-Effective Design due to Piezoresistive Sensors**
- **Compatible w/ Leading Image Acquisition Software Package**
- **Closed-Loop Control for High Repeatability and Accuracy**
- **Millisecond Step Time, Ideal for Super-Resolution Microscopy**
- **24-Bit Controller w/ USB, Ethernet, RS-232 Interface and Analog Control**
- **Available Manual Long-Travel Stage with Motor Upgrade Option**

Long Travel, Low Profile, Optimized for Microscopy

PI nano™ XY and XYZ low-profile piezo scanning stages are optimized for easy integration into high-resolution microscopes. They feature a very low profile of 20 mm (0.8") and a large aperture designed to hold Petri dishes and standard slide holders. The long travel ranges of up to 200 x 200 x 200 µm with nanometer closed-loop resolution are ideal for leading-edge microscopy and imaging applications.

Application Examples

- Super-resolution microscopy
- 3D Imaging
- Laser technology
- Interferometry
- Metrology
- Biotechnology
- Screening
- Micromanipulation

Cost Effective Design, High Performance

PI nano™ series piezo positioning stages are designed to provide high performance at minimum cost. For highly-stable, closed loop operation, piezoresistive sensors are applied directly to the moving structure and precisely measure the displacement of the stage platform. The very high sensitivity of these sensors provides optimum position stability and responsiveness as well as nanometer resolution. A proprietary servo controller significantly improves the motion linearity compared to conventional piezoresistive sensor controllers.

High Reliability and Long Lifetime

The compact P-545 systems are equipped with preloaded PICMA® high-performance piezo actuators which are integrated into a sophisticated, FEA-modeled, flexure guiding system. The PICMA® actuators feature cofired ceramic encapsulation and provide better performance and reliability than conventional piezo actuators. Actuators, guidance and sensors are maintenance-free, not subject to wear and offer extraordinary reliability.

Background: the piezo controller is included and comes with a 24-bit resolution USB port as well as ethernet, RS-232 and analog interface. Foreground: The optional M-545 manual XY stage provides a stable platform for the PI nano™ piezo stages. Custom stage version shown

Ordering Information

P-545.2R7
Plnano™ XY Piezo Stage, Slide-Size Aperture, 200 x 200 µm, Piezoresistive Sensors, with USB Controller

P-545.3R7
Plnano™ XYZ Piezo Stage, Slide-Size Aperture, 200 x 200 x 200 µm, Piezoresistive Sensors, with USB Controller

Controller included

E-545.3RD
Plnano™ Multi-Channel Piezo Controller with High-Speed Digital Interface, 3 Channels, Piezoresistive Sensors, Sub-D Connectors

Accessories

M-545.2MO
XY Microscope Stage, 25 x 25 mm, Micrometer-Driven, High Stability, Compatible with PI® Piezo Stages, for Olympus Microscopes

M-545.2MN
XY Microscope Stage, 25 x 25 mm, Micrometer-Driven, High Stability, Compatible with PI® Piezo Stages, for Nikon Microscopes

M-545.2ML
XY Microscope Stage, 25 x 25 mm, Micrometer-Driven, High Stability, Compatible with PI® Piezo Stages, for Leica Microscopes

M-545.2MZ
XY Microscope Stage, 25 x 25 mm, Micrometer-Driven, High Stability, Compatible with PI® Piezo Stages, for Zeiss Microscope

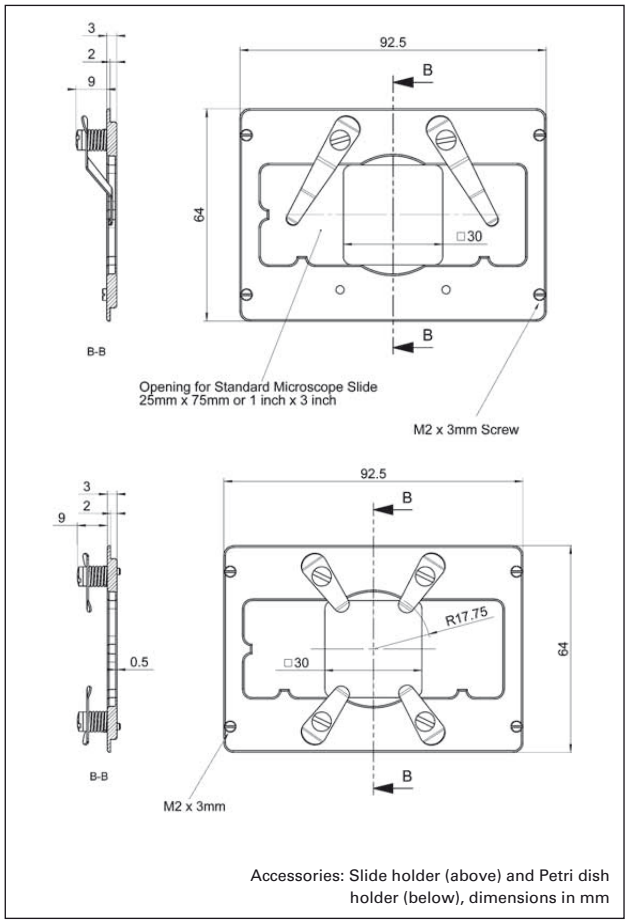
P-545.PD3
35mm Petri Dish Holder for P-545 Plnano™ Piezo Stages

P-545.SH3
Microscope Slide Holder for Plnano™ Piezo Stages

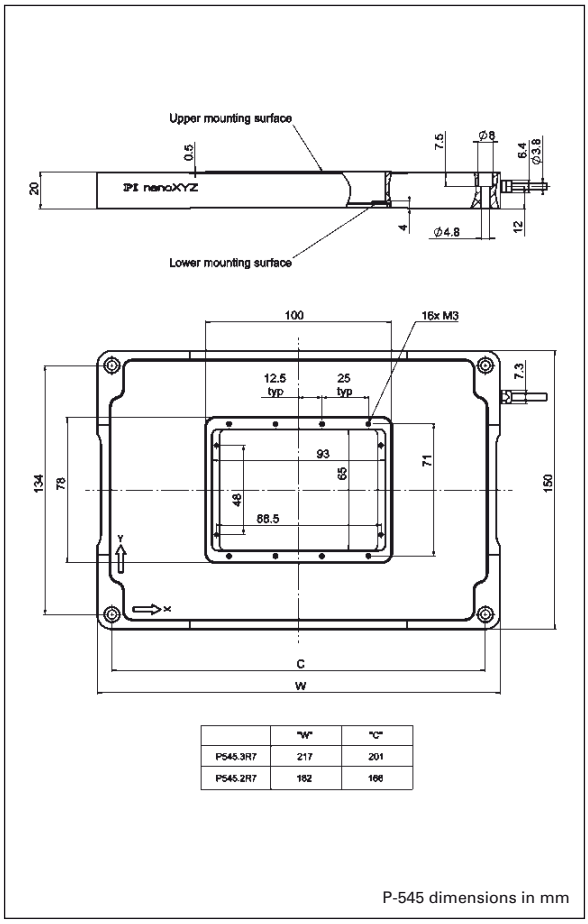
P-545.PP3
Plain Plate for Accessories for Plnano™ Piezo Stages

Additional accessories on request.

Capacitive Sensor Version and High Speed Tracking Version also Available



Accessories: Slide holder (above) and Petri dish holder (below), dimensions in mm



	"W"	"C"
P545.3R7	217	201
P545.2R7	182	166

P-545 dimensions in mm

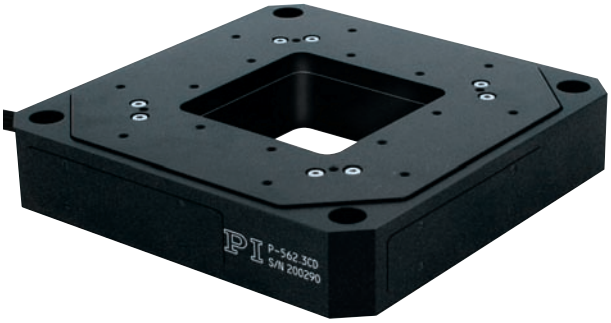
Technical Data

Model	P-545.2R7	P-545.3R7	Unit	Tolerance
Active axes	X, Y	X, Y, Z		
Motion and positioning				
Integrated sensor	piezoresistive	piezoresistive		
Closed-loop travel	200 x 200	200 x 200 x 200	µm	
Closed-loop resolution*	1	1	nm	typ.
Linearity	±0.1	±0.1	%	typ.
Repeatability	< 5	< 5	nm	typ.
Mechanical properties				
Push/pull force capacity	100 / 30	100 / 30	N	max.
Load	50	50	N	max.
Drive properties				
Ceramic type	PICMA® P-885	PICMA® P-885		
Electrical capacitance	6	6 (X, Y), 12 (Z)	µF	±20%
Miscellaneous				
Operating temperature range	-20 to 80	-20 to 80	°C	
Material	Aluminum	Aluminum		
Mass	1	1.2	kg	±5%
Cable length	1.5	1.5	m	±10 mm
Sensor / voltage connection	Sub-D, 25 pin	Sub-D, 25 pin		
Piezo controller (included in delivery)	E-545	E-545		

* Resolution of PI Piezo Nanopositioners is not limited by friction or stiction. Value given is noise equivalent motion measured with interferometer.

P-561 · P-562 · P-563 PIMars™ XYZ Piezo System

High-Precision Nanopositioning Stage, 3 to 6 Axes



P-562 PIMars™ multi-axis, parallel-kinematics nanopositioning stages are available with up to 340 µm travel per axis. Custom versions to 6 DOF are available

- **Parallel-Kinematics / Metrology for Enhanced Responsiveness / Multi-Axis Precision**
- **Travel Ranges to 340 x 340 x 340 µm**
- **Capacitive Sensors for Highest Linearity**
- **Frictionless, High-Precision Flexure Guiding System**
- **Excellent Scanning Flatness**
- **High-Dynamics XYZ Version Available; Custom Versions to 6-DOF**
- **Clear Aperture 66 x 66 mm**
- **Outstanding Lifetime Due to PICMA® Piezo Actuators**
- **UHV Versions to 10^{-9} hPa**

PIMars™ open-frame piezo stages are fast and highly accurate multi-axis scanning and nanopositioning systems with flatness and straightness in the nanometer range.

The 66 x 66 mm clear aperture is ideal for transmitted-light applications such as near-field scanning or confocal microscopy and mask positioning.

Large Variety of Models

PIMars™ multi-axis nanopositioners are offered in a large variety of configurations. Standard models include long-travel systems (to 300 x 300 x 300 µm), high-speed and vacuum versions. Custom six-axis designs with rotation to 6 mrad are available on request.

PI offers versions specially designed for applications in ultra-high vacuum with vacuum-qualified components only. The integrated ceramic-encapsulated PICMA® actuators allow high bakeout temperatures and assure minimal outgassing rates. A non-magnetizable version is available on request.

Application Examples

- Scanning microscopy
- Mask/wafer positioning
- Interferometry
- Metrology
- Biotechnology
- Micromanipulation

Direct Drive for Ultra-Fast Scanning and Positioning

The P-561.3DD versions have resonant frequencies to 1.0 kHz, enabling millisecond scanning rates with sub-nanometer resolution.

Capacitive Sensors for Highest Accuracy and Position Stability

PI's proprietary capacitive sensors measure position directly and without physical contact. They are free of friction and hysteresis, a fact which, in combination with the positioning resolution of well under 1 nm, makes it possible to achieve very high levels of linearity. A further advantage of direct metrology with capacitive sensors is the high phase fidelity and the high bandwidth of up to 10 kHz.

Active and Passive Guidance for Nanometer Flatness and Straightness

Wire-cut flexures optimized with Finite Element Analysis (FEA) are used to guide the stage. The FEA techniques give the design the highest possible stiffness and minimize linear and angular runout. Further enhancement is achieved by active trajectory control: multi

Ordering Information

P-561.3CD
PIMars™ XYZ Piezo-Nanopositioning System, 100 x 100 x 100 µm, Parallel Metrology

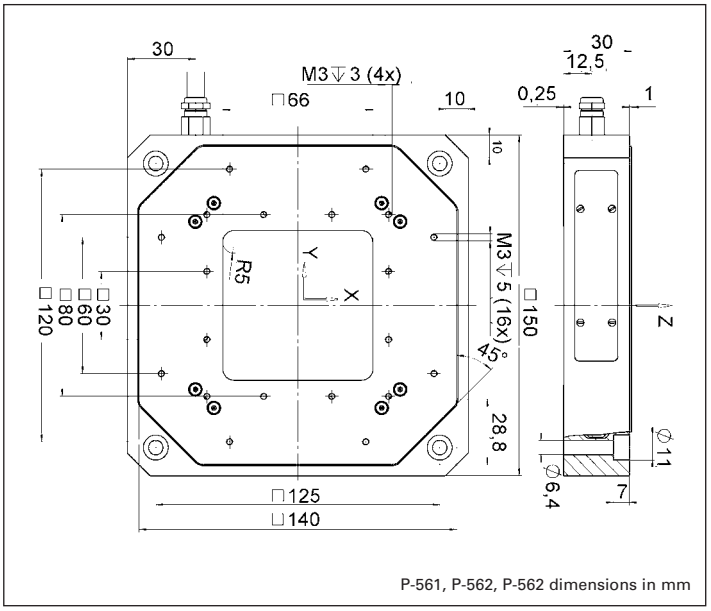
P-562.3CD
PIMars™ XYZ Piezo-Nanopositioning System, 200 x 200 x 200 µm, Parallel Metrology

P-563.3CD
PIMars™ XYZ Piezo-Nanopositioning System, 300 x 300 x 300 µm, Parallel Metrology

P-561.3DD
PIMars™ High-Dynamics XYZ Nanopositioning System, 45 x 45 x 15 µm, Parallel Metrology, Direct Drive

Vacuum-compatible versions to 10^{-6} hPa for the P-561.3CD, P-562.3CD and P-563.3CD models are available as P-561.3VD, P-562.3VD and P-563.3VD; versions to 10^{-9} hPa as P-561.3UD, P-562.3UD and P-563.3UD.

Super-invar & titanium versions are available, 6-DOF versions on request.

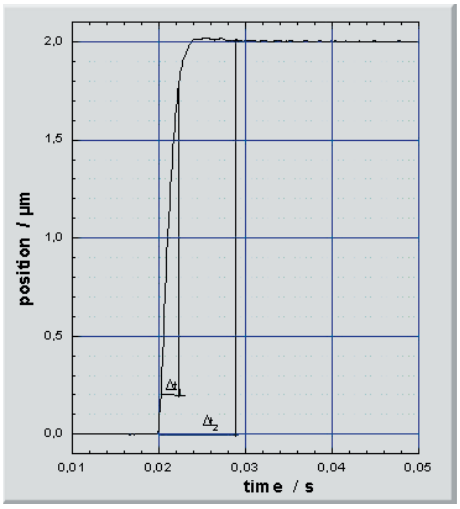


P-561, P-562, P-562 dimensions in mm

System properties

System Configuration	P-561.3CD with E-710 digital controller, 330 g load
Amplifier bandwidth, small signal	25 Hz in X, Y; 35 Hz in Z
Settling time (10 % step)	20 ms

axis nanopositioning systems equipped with parallel metrology are able to measure platform position in all degrees of freedom against a common, fixed reference. In such systems, undesirable motion from one actuator in the direction of another (cross-talk) is detected immediately and actively compensated by the servo-loops. This can keep deviation from a trajectory to under a few nanometers, even in dynamic operation.



P-562.3CD (unloaded) step and settle is faster than 10 ms in X, Y and Z

Technical Data

Model	P-561.3CD	P-562.3CD	P-563.3CD	P-561.3DD	Units	Tolerance
Active axes	X, Y, Z	X, Y, Z	X, Y, Z	X, Y, Z		
Motion and positioning						
Integrated sensor	Capacitive	Capacitive	Capacitive	Capacitive		
Open-loop travel, -20 to +120 V	150 x 150 x 150	300 x 300 x 300	340 x 340 x 340	58 x 58 x 18	µm	min. (+20 %/0 %)
Closed-loop travel	100 x 100 x 100	200 x 200 x 200	300 x 300 x 300	45 x 45 x 15	µm	
Open-loop resolution	0.2	0.4	0.5	0.1	nm	typ.
Closed-loop resolution	0.8	1	2	0.2	nm	typ.
Linearity	0.03	0.03	0.03	0.01*	%	typ.
Repeatability in X, Y, Z	2 / 2 / 2	2 / 2 / 4	2 / 2 / 4	2 / 2 / 2	nm	typ.
Pitch in X,Y	±1	±2	±2	±3	µrad	typ.
Runout θ_x, θ_y (Z motion)	±15	±20	±25	±3	µrad	typ.
Yaw in X, Y	±6	±10	±10	±3	µrad	typ.
Flatness in X, Y	±15	±20	±25	±10	nm	typ.
Crosstalk X, Y (Z motion)	±30	±50	±50	±20	nm	typ.
Mechanical properties						
Unloaded resonant frequency in X / Y / Z	190 / 190 / 380	160 / 160 / 315	140 / 140 / 250	920 / 920 / 1050**	Hz	±20 %
Resonant frequency @ 100 g in X / Y / Z	–	145 / 145 / 275	120 / 120 / 215	860 / 860 / 950	Hz	±20 %
Resonant frequency @ 330 g in X / Y / Z	140 / 140 / 300	130 / 130 / 195	110 / 110 / 170	500 / 500 / 470	Hz	±20 %
Push force capacity in motion direction in X / Y / Z	200 / 200 / 50	120 / 120 / 50	100 / 100 / 50	200 / 200 / 50	N	Max.
Pull force capacity in motion direction in X / Y / Z	30 / 30 / 30	30 / 30 / 30	30 / 30 / 30	30 / 30 / 30		
Load capacity	50	50	50	50	N	Max.
Drive properties						
Ceramic type	PICMA® P-885	PICMA® P-885	PICMA® P-885	PICMA® P-885 in Z, P-888 in XY		
Electrical capacitance in X / Y / Z	5.2 / 5.2 / 10.4	7.4 / 7.4 / 14.8	7.4 / 7.4 / 14.8	38 / 38 / 6	µF	±20 %
Dynamic operating current coefficient (DOCC) in X / Y / Z	6.5 / 6.5 / 13	4.6 / 4.6 / 9.25	3.1 / 3.1 / 6.1	106 / 106 / 50	µA/ (Hz • µm)	±20 %
Miscellaneous						
Operating temperature range	-20 to 80	-20 to 80	-20 to 80	-20 to 80	°C	
Material	Aluminum	Aluminum	Aluminum	Aluminum		
Mass	1.45	1.45	1.45	1.55	kg	±5 %
Cable length	1.5	1.5	1.5	1.5	m	±10 mm
Sensor / voltage connection	Sub-D Special	Sub-D Special	Sub-D Special	Sub-D Special		

Resolution of PI Piezo Nanopositioners is not limited by friction or stiction. Value given is noise equivalent motion with E-710 (p. 2-128) controller.
*With digital controller. Non-linearity of direct drive stages measured with analog controllers is typically up to 0.1 %.

Recommended controller
Multi-channel digital controllers: E-710 bench-top (p. 2-128), E-712 modular (p. 2-140), E-725 high-power (p. 2-126), E-761 PCI board (p. 2-130)

P-517 · P-527 Piezo Scanner: XY, XYZ, XY-Theta-Z

High-Dynamics Nanoscanner for Scanning Probe Microscopy

P-527.2CL parallel-kinematic nanopositioning system

- **Travel Ranges to 200 µm**
- **Sub-Nanometer Resolution**
- **Frictionless, High-Precision Flexure Guiding System**
- **Capacitive Sensors for Highest Linearity**
- **Parallel-Kinematics / Metrology for Enhanced Responsiveness / Multi-Axis Precision**
- **Clear Aperture 66 x 66 mm**
- **Outstanding Lifetime Due to PICMA® Piezo Actuators**

P-517 and P-527 high-dynamics, multi-axis piezo-nanopositioning stages are available in XY ΘZ, XY and XYZ configurations featuring linear travel ranges to 200 x 200 x 20 µm and rotation ranges to 4 mrad. The 66 x 66 mm clear aperture is ideal for transmitted-light applications.
Z/tip/tilt versions in the same form factor are also offered as models P-518, P-528, P-558 (see p. 2-46) and as custom versions with up to six degrees of freedom.

Capacitive Sensors for Highest Accuracy

PI's proprietary capacitive sensors measure position directly and without physical contact. They are free of friction and hysteresis, a fact which, in combination with the positioning resolution of well under 1 nm, makes it possible to achieve very high levels of linearity. A further advantage of direct metrology with capacitive sensors is the high phase fidelity and the high bandwidth of up to 10 kHz.

Application Examples

- Metrology
- Interferometry
- Optics
- Lithography
- Nanopositioning
- Scanning microscopy
- Mass storage device testing
- Laser technology
- Micromachining

Technical Data

Model	P-517.2CL	P-527.2CL	P-517.3CL/ P-517.3CD	P-527.3CL/ P-527.3CD	P-517.RCD	P-527.RCD
Active axes	X, Y	X, Y	X, Y, Z	X, Y, Z	X, Y, θ_z	X, Y, θ_z
Motion and positioning						
Integrated sensor	Capacitive	Capacitive	Capacitive	Capacitive	Capacitive	Capacitive
Open-loop travel, -20 to +120 V	130	250	130; Z: 25	250; Z: 25	130; θ_z: ±1.3 mrad	250; θ_z: ±2.5 mrad
Closed-loop travel	100	200	100; Z: 20	200; Z: 20	100; θ_z: ± 1 mrad	200; θ_z: ± 2 mrad
Open-loop resolution	0.3	0.5	0.3; Z: 0.1	0.5; Z: 0.1	0.3; θ_z: ±0.1 µrad	0.5; θ_z: ±0.1 µrad
Closed-loop resolution	1	2	1; Z: 0.1	2; Z: 0.1	1; θ_z: ±0.3 µrad	2; θ_z: ±0.3 µrad
Linearity	0.03	0.03	0.03	0.03	0.03	0.03
Repeatability	±5	±10	±5; Z: ±1	±10; Z: ±1	±5; θ_z: ±0.5 µrad	±10; θ_z : ±1 µrad
Mechanical properties						
Stiffness	2	1	2; Z: 15	1; Z: 15	2	1
Unloaded resonant frequency	450	350	450; Z: 1100	350; Z: 1100	450; θ_z: 400	350; θ_z: 300
Resonant frequency @ 500 g X, Y	250	190	250	190	250	190
Resonant frequency @ 2500 g X, Y	140	110	140	110	140	110
Push/pull force capacity in motion direction	50 / 30	50 / 30	50 / 30	50 / 30	50 / 30	50 / 30
Drive properties						
Ceramic type	PICMA® P-885	PICMA® P-885	PICMA® P-885	PICMA® P-885	PICMA® P-885	PICMA® P-885
Electrical capacitance	9.2	9.2	9; Z: 6	9; Z: 6	9	9
Dynamic operating current coefficient (DOCC)	11.5	5.8	11.5; Z: 37	5.5; Z: 37	11.5	5.5
Miscellaneous						
Operating temperature range	-20 to 80	-20 to 80	-20 to 80	-20 to 80	-20 to 80	-20 to 80
Material	Aluminum	Aluminum	Aluminum	Aluminum	Aluminum	Aluminum
Mass	1.4	1.4	1.45	1.45	1.4	1.4
Sensor / voltage connection	LEMO	LEMO	Sub-D special (CD-version) LEMO (CL-version)	Sub-D special (CD-version) LEMO (CL-version)	Sub-D Special	Sub-D Special

Resolution of PI Piezo Nanopositioners is not limited by friction or stiction. Value given is noise equivalent motion with E -503 or E-710 controller (p. 2-146 or p. 2-128)
Linear Dynamic Operating Current Coefficient in µA per Hz and µm. Example for P-527.2xx: Sinusoidal scan of 30 µm at 10 Hz requires approximately 1.8 mA drive current (p. 2-70). Electrical capacitance and DOCC of the rotation axes base upon differential motion in X, Y; therefore not stated.
Recommended controller
Versions with LEMO connectors: Single-channel (1 per axis): E-610 servo-controller / amplifier (p. 2-110), E-625 servo-controller, bench-top (p. 2-114), E-621 controller module (p. 2-160) Multi-channel: modular piezo controller system E-500 (p. 2-142) with amplifier module E-503 (three channels) (p. 2-146) or E-505 (1 per axis, high-power) (p. 2-147) and E-509 controller (p. 2-152)
Versions with Sub-D connectors: Multi-channel digital controllers: E-710 bench-top (p. 2-128), E-712 modular (p. 2-140), E-725 high-power (p. 2-126), E-761 PCI board (p. 2-130)

Active and Passive Guidance for Nanometer Flatness and Straightness

Flexures optimized with Finite Element Analysis (FEA) are used to guide the stage. The FEA techniques provide for the highest possible stiffness in, and perpendicular to, the direction of motion, and minimize linear and angular runout. Flexures allow extremely high-precision motion, no matter how minute, as they are completely free of play and friction. Due to the parallel kinematics design there is only one common moving platform for all axes, minimizing mass, enabling identical dynamic behavior and eliminating cumulative errors. Parallel kinematics also allows for a more compact construction and faster response compared to stacked or nested designs. The high precision due to flexure guidance is further enhanced by Active Trajectory Control: Multi-axis nanopositioning systems equipped with both parallel kinematics and parallel direct metrology are able to measure platform position in all degrees of freedom against one common fixed reference. In such systems, undesirable motion from one actuator in the direction of another (cross-talk) is detected immediately and actively compensated by the servo-loops. This Active Trajectory Control Concept can keep deviation from a trajectory to under a few nanometers, even in dynamic operation.

Ceramic Insulated Piezo Actuators Provide Long Lifetime

Highest possible reliability is assured by the use of award-winning PICMA® multilayer piezo actuators. PICMA® actuators are the only actuators on the market with ceramic-only insulation, which makes them resistant to ambient humidity and leakage-current failures. They are thus far superior to conventional actuators in reliability and lifetime.

	Units	Tolerance
	µm	min.(+20%/0%)
	µm	
	nm	typ.
	nm	typ.
	%	typ.
	nm	typ.
	N/µm	±20%
	Hz	±20%
	Hz	±20%
	Hz	±20%
	N	Max.
	µF	±20%
	µA/(Hz • µm)	±20%
	°C	
	kg	±5%

Ordering Information

P-517.2CL
Precision XY Nanopositioning System, 100 x 100 µm, Capacitive Sensors, Parallel Metrology, LEMO Connector

P-527.2CL
Precision XY Nanopositioning System, 200 x 200 µm, Capacitive Sensors, Parallel Metrology, LEMO Connector

P-517.3CL
Precision XYZ Nanopositioning System, 100 x 100 x 20 µm, Capacitive Sensors, Parallel Metrology, LEMO Connector

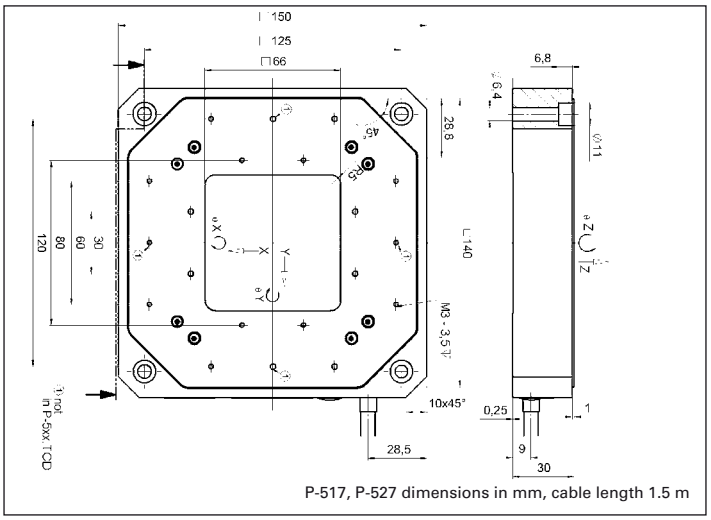
P-517.3CD
Precision XYZ Nanopositioning System, 100 x 100 x 20 µm, Capacitive Sensors, Parallel Metrology, Sub-D Connector

P-527.2CL
Precision XY Nanopositioning System, 200 x 200 µm, Capacitive Sensors, Parallel Metrology, LEMO Connector

P-527.3CD
Precision XYZ Nanopositioning System, 200 x 200 x 20 µm, Capacitive Sensors, Parallel Metrology, Sub-D Connector

P-517.RCD
Precision XY / Rotation Nanopositioning System, 100 x 100 µm, 2 mrad, Capacitive Sensors, Parallel Metrology, Sub-D Connector

P-527.RCD
Precision XY / Rotation Nanopositioning System, 200 x 200 µm, 4 mrad, Capacitive Sensors, Parallel Metrology, Sub-D Connector



P-517, P-527 dimensions in mm, cable length 1.5 m

P-733.2 · P-733.3 XY / XYZ Piezo-Nanopositioning Stage

High-Precision Piezo Scanner Family with Aperture: Performance for STED Microscopy

P -733.3 DD (left) and P -733.2 DD, high-speed, direct drive XY(Z) scanning stages are the fastest scanning stages with large aperture currently available (2.2 kHz resonant frequency!). Both units feature a footprint of only 100 x 100 mm. CD for size comparison.

- **Travel Ranges to 100 x 100 µm in X,Y & to 10 µm in Z**
- **Resolution to 0.1 nm with Capacitive Sensors**
- **High-Speed Versions with Direct Drive**
- **Vacuum and Non-Magnetic Versions**
- **Parallel Kinematics for Better Multi-Axis Accuracy /Dymanics**
- **The Standard in STED Microscopy**
- **Parallel Metrology for Active Trajectory Control**
- **Frictionless, High-Precision Flexure Guiding System**
- **Clear Aperture 50 x 50 mm for Transmitted-Light Applications**

P-733 XY and XYZ piezo driven stages are fast and highly accurate nanopositioning and scanning systems. They provide a positioning and scanning range of 100 x 100 (x10) µm together with sub-nanometer resolution and are equipped with parallel-metrology capacitive position feedback for superior multi-axis linearity and repeatability. The guiding accuracy minimizes runout to under 10 nm over the whole travel range. In addition, the high-speed Z-axis of the P-733.3CD can actively compensate any out-of-plane Z-axis deviation during XY motion.

Application Examples

- Image processing / stablilization
- Scanning microscopy
- Surface inspection
- Metrology / interferometry
- Biotechnology
- Semiconductor testing
- Mask / wafer positioning
- Micromanipulation
- Nanopositioning with high flatness & straightness

Fastest Multi-Axis Systems / Direct Drive, Low Profile and Large Apertures

P-733.2DD / .3DD multi-axis piezo nanopositioning systems are the fastest ultra-high-precision, open-frame stages for scanning microscopy. They provide a positioning and scanning range of 30 x 30 (x10) µm. P-733 nanopositioning and scanning stages feature very low profiles, as low as 20 mm (0.8 inch). The novel, high-stiffness direct drive gives the systems resonant frequencies as high as 2.2 kHz (4 x that of other comparable systems), enabling millisecond scanning rates with sub-nanometer resolution.

Parallel-Kinematics / Metrology for Enhanced Responsiveness

In a parallel kinematics multi-axis system, all actuators act directly on one moving platform. This means that all axes move the same minimized mass and can be designed with identical dynamic properties. Multi-axis nanopositioning systems equipped with both parallel kinematics and parallel, direct metrology are able to measure platform position in all degrees of freedom against one common fixed reference. In such systems, undesirable motion from one actuator in the direction of another (cross talk) is detected immediately and actively compensated by the servo-loops.

Capacitive Sensors for Subnanometer Resolution

PI's proprietary capacitive sensors measure position directly and without physical contact. They are free of friction and hysteresis, a fact which, in combination with the positioning resolution of well under 1 nm, makes it possible to achieve very high levels of linearity. A further advantage of direct metrology with capacitive sensors is the high phase fidelity and the high bandwidth of up to 10 kHz. The closed-loop resolution is 0.3 nm for the X and Y axes and 0.2 nm for the optional Z-axis. The direct drive versions are rated to 0.1 nm resolution for every axis.

Large Variety of Models for a Broad Range of Applications

For Z-axis scanning applications, the P-733.ZCD (see p. 2-42) version is available with a travel range of 100 µm. For ultra-high-vacuum applications down to 10^{-9} hPa, nanopositioning systems as well as comprehensive accessories, such as suitable feedthroughs, are available.

Ordering Information

P-733.2DD
High-Dynamics High-Precision XY Nanopositioning System, 30 x 30 µm, Direct Drive, Capacitive Sensors, Parallel Metrology, Sub-D Connector

P-733.3DD
High-Dynamics Precision XYZ Nanopositioning System, 30 x 30 x 10 µm, Direct Drive, Capacitive Sensors, Parallel Metrology, Sub-D Connector

P-733.2CD* / P-733.2CL*
High-Precision XY Nanopositioning System, 100 x 100 µm, Capacitive Sensors, Parallel Metrology

P-733.3CD* / P-733.3CL*
Precision XYZ Nanopositioning System, 100 x 100 x 10 µm, Capacitive Sensors, Parallel Metrology

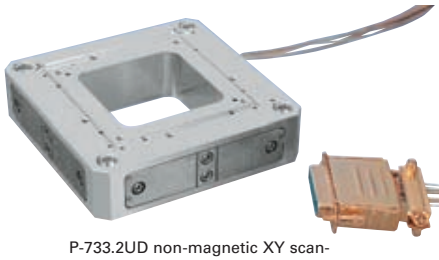
P-733.2VL* / P-733.2VD*
High-Precision XY Nanopositioning System, 100 x 100 µm, Capacitive Sensors, Parallel Metrology, Vacuum Compatible to 10-6 hPa

P-733.2UD
High-Precision XY Nanopositioning System, 100 x 100 µm, Capacitive Sensors, parallel metrology, Sub-D Connector, Vacuum Compatible to 10-9 hPa

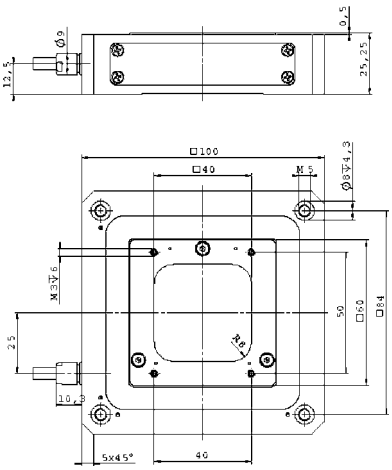
*.xxD with Sub-D Connector

*.xxL with LEMO Connector

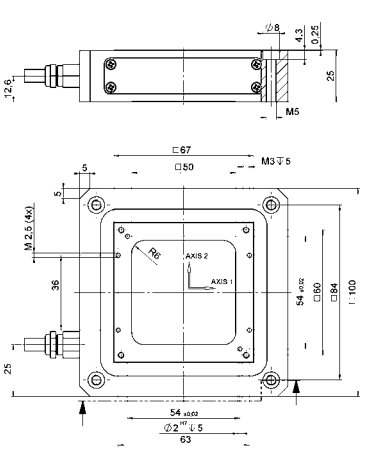
Ask about custom designs



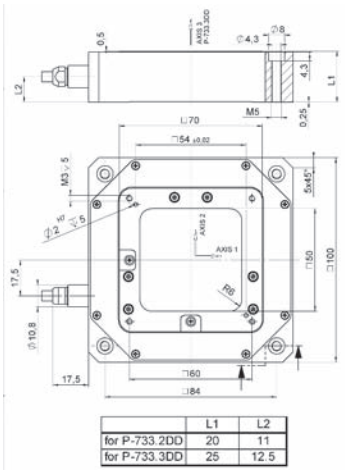
P-733.2UD non-magnetic XY scanning stage for UHV to 10^{-9} hPa



P-733.3 dimensions in mm



P-733.2 dimensions in mm



P-733.xDD dimensions in mm

Technical Data

Model	P-733.2CD P-733.2CL	P-733.3CD P-733.3CL	P-733.2DD	P-733.3DD	Units	Tolerance
Active axes	X, Y	X, Y, Z	X, Y	X, Y, Z		
Motion and positioning						
Integrated sensor	Capacitive	Capacitive	Capacitive	Capacitive		
Open-loop travel, -20 to +120 V	115 x 115	115 x 115 x 12	33 x 33	33 x 33 x 14	µm	min. (+20 %/-0 %)
Closed-loop travel	100 x 100	100 x 100 x 10	30 x 30	30 x 30 x 10	µm	
Open-loop resolution	0.2	0.2 (0.1 in Z)	0.1	0.1	nm	typ.
Closed-loop resolution	0.3	0.3 (0.2 in Z)	0.1	0.1	nm	typ.
Linearity (X, Y)	0.03	0.03	0.03*	0.03*	%	typ.
Linearity (Z)	–	0.03	–	0.03*	%	typ.
Repeatability (X, Y)	<2	<2	<2	<2	nm	typ.
Repeatability (Z)	–	<1	–	<1	nm	typ.
Pitch (X,Y)	<±3	<±3	<±5	<±5	µrad	typ.
Yaw (X, Y)	<±10	<±10	<±10	<±10	µrad	typ.
Runout θZ (motion in Z)		<±5		<±5	µrad	typ.
Mechanical properties						
Stiffness	1.5	1.4 (9 in Z)	20	4 (10 in Z)	N/µm	±20 %
Unloaded resonant frequency	500	460 (1400 in Z)	2230	1200 (1100 in Z)	Hz	±20 %
Resonant frequency @ 120 g	370	340 (1060 in Z)	-	-	Hz	±20 %
Resonant frequency @ 200 g	340	295 (650 in Z)	1550	530 (635 in Z)	Hz	±20 %
Push/pull force capacity in motion direction	50/20	50/20	50/20	50/20	N	Max.
Drive properties						
Ceramic type	PICMA® P-885	PICMA® P-885	PICMA® P-885	PICMA® P-885		
Electrical capacitance	6	6 (2.4 in Z)	6.2	6.2 (3.3 in Z)	µF	±20 %
Dynamic operating current coefficient	7.5	7.5 (30 in Z)	25	25 (41 in Z)	µA	(Hz • µm) ±20 %
Miscellaneous						
Operating temperature range	-20 to 80	-20 to 80	-20 to 80	-20 to 80	°C	
Material	Aluminum	Aluminum	Aluminum	Aluminum		
Mass	0.58	0.675	0.58	0.675	kg	±5 %
Cable length	1.5	1.5	1.5	1.5	m	±10 mm
Sensor/ voltage connection	Sub-D special (CD-version) LEMO (CL-version)	Sub-D special (CD-version) LEMO (CL-version)	Sub-D special	Sub-D special		

*With digital controller. Non-linearity of direct drive stages measured with analog controllers is up to 0.1 % typ.

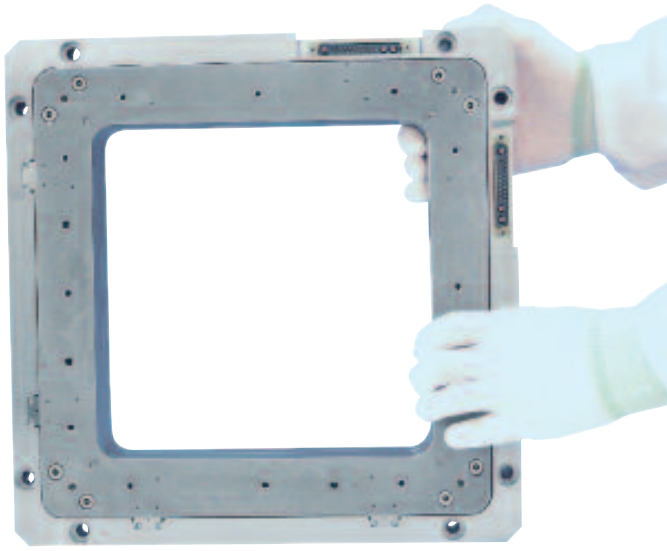
Recommended controller:
Single-channel (1 per axis): E-610 servo controller / amplifier (p. 2-110), E -625 servo controller, bench-top (p. 2-114), E-621 controller module (p. 2-160)
Multi-channel: modular piezo controller system E-500 (p. 2-142) with amplifier module E-503 (three channels) (p. 2-146) or E-505 (1 per axis, high-power) (p. 2-147) and E-509 controller (p. 2-152)
Multi-channel digital controllers: E-710 bench-top (p. 2-128), E-712 modular (p. 2-140), E-725 high-power (p. 2-126), E-761 PCI board (p. 2-130)

P-915K Vacuum Compatible XYZ Piezo Scanner

Large Clear Aperture, High-Dynamics, High-Load Nanopositioner

- **Vacuum Compatible to 10^{-6} hPa**
- **Direct Metrology with Capacitive Sensors**
- **Excellent Straightness: <0.1 µrad Runout**
- **Frictionless, High-Precision Flexure Guiding System**
- **Direct Metrology with Capacitive Sensors**

Model	Travel	Re-solution	Resonant frequency	Load capacity	Dimensions
P-915KLVS Large XYZ Scanner	100 x 100 x 100 µm	1 nm	110 Hz (X,Y) 230 Hz (Z)	50 kg	340 x 340 x 60 mm Clear aperture 200 x 200 mm



The P-915KLVS high-dynamics scanner offers a very large clear aperture of 200 x 200 mm

P-363 PicoCube™ XYZ and XY Piezo Scanner for AFM

High-Dynamics Nanoscanner for Scanning Probe Microscopy

P-363.2CD and .3CD (background) PicoCube™, high-performance piezo positioning- and scanning systems or AFM/STM and nanomanipulation.

- **Ultra-High-Performance Closed-Loop Scanner for AFM/SPM**
- **Compact Manipulation Tool for Bio/Nanotechnology**
- **Resonant Frequency 9.8 kHz**
- **Capacitive Sensors for Highest Accuracy**
- **Parallel-Motion Metrology for Automated Compensation of Guiding Errors**
- **50 Picometer Resolution**
- **5 x 5 x 5 µm Travel Range**
- **Vacuum-Compatible Versions**

The P-363 PicoCube™ XY/XYZ is an ultra-high-performance closed-loop piezo scanning system. Designed for AFM, SPM and nanomanipulation applications, it combines an ultra-low inertia, high-speed XY/XYZ piezo scanner with non-contact, direct-measuring, parallel-metrology capacitive feedback capable of 50 picometers resolution. On top of being extremely precise, the PicoCube™ system is also very small and rugged. Measuring only 30 x 30 x 40 mm (with removable top plate, 30 x 30 x 28 mm for XY version), it is easy to integrate in any scanning apparatus.

Application Examples

- Scanning microscopy (SPM)
- Biotechnology
- Micromanipulation
- Nanopositioning
- Nano-imprinting
- Nanometrology
- Nanolithography

SPM, AFM, STM, Nanolithography, Nanoimprinting, Nanometrology

The PicoCube™ was specifically developed to overcome the limitations of the open-loop scanners currently available for SPM, AFM and STM. In addition to these applications, the PicoCube™ is also the ideal scanning and manipulation tool for nanoimprinting, nanolithography, ultra-high-resolution, near-field, scanning optical microscopy and nanosurface-metrology applications.

Higher Precision Through Parallel-Motion Metrology w/ Capacitive Sensors

The PicoCube™ is based on a proprietary, ultra-fast, piezo-driven scanner design equipped with direct-measuring, capacitive position sensors (parallel metrology). Unlike conventional sensors, they measure the actual distance between the fixed frame and the moving part of the stage. This results in higher-motion linearity, long-term stability, phase fidelity, and—because external disturbances are seen by the sensor immediately—a stiffer, faster-responding servo-loop.

Multi-axis nanopositioning systems equipped with parallel direct metrology are able to measure the platform position in all degrees of freedom against one fixed reference. In such systems, undesirable motion from one actuator in the direction of another (cross-talk) is detected immediately and act ively compensated by the servo-loops. This Active Trajectory Control Concept can keep deviation from a trajectory to under a few nanometers, even in dynamic operation.

Ordering Information

P-363.3CD
PicoCube™ High-Precision XYZ Nanopositioning System, 5 x 5 x 5 µm, Parallel Metrology, Capacitive Sensors, Sub-D Connector

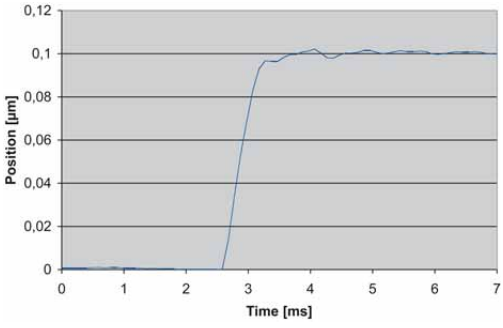
P-363.3UD
PicoCube™ High-Precision XYZ Nanopositioning System, 5 x 5 x 5 µm, Parallel Metrology, Capacitive Sensors, Sub-D Connector, Vacuum Compatible to 10^{-9} hPa

P-363.2CD
PicoCube™ High-Precision XY Nanopositioning System, 5 x 5 µm, Parallel Metrology, Capacitive Sensors, Sub-D Connector

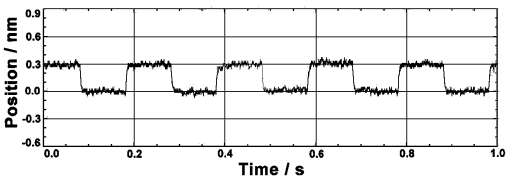
P-363.2UD
PicoCube™ High-Precision XY Nanopositioning System, 5 x 5 µm, Parallel Metrology, Capacitive Sensors, Sub-D Connector, Vacuum Compatible to 10^{-9} hPa

P-363.3CL
PicoCube™ High-Precision XYZ Nanopositioning System, 5 x 5 x 5 µm, Parallel Metrology, Capacitive Sensors, LEMO Connector

P-363.2CL
PicoCube™ High-Precision XY Nanopositioning System, 5 x 5 µm, Parallel Metrology, Capacitive Sensors, LEMO Connector



The P-363 settles to within 1 nm in 1 ms (100 nm step, X and Y motion; faster response in Z)



300 picometer steps (0.3 nm) performed with the P-363, measured with an external high-resolution, capacitive measurement system

Nanometer Accuracy in 1 Millisecond with 30-Picometer Resolution

PicoCube™ systems provide resolution of 30 picometers and below. The ultra-fast XY/XYZ piezo drives offer resonant frequencies of 9.8 kHz in Z and >3 kHz in X and Y! The high resonant frequency and high-bandwidth capacitive feed back allow step and settle to 1% accuracy in as little as one millisecond.

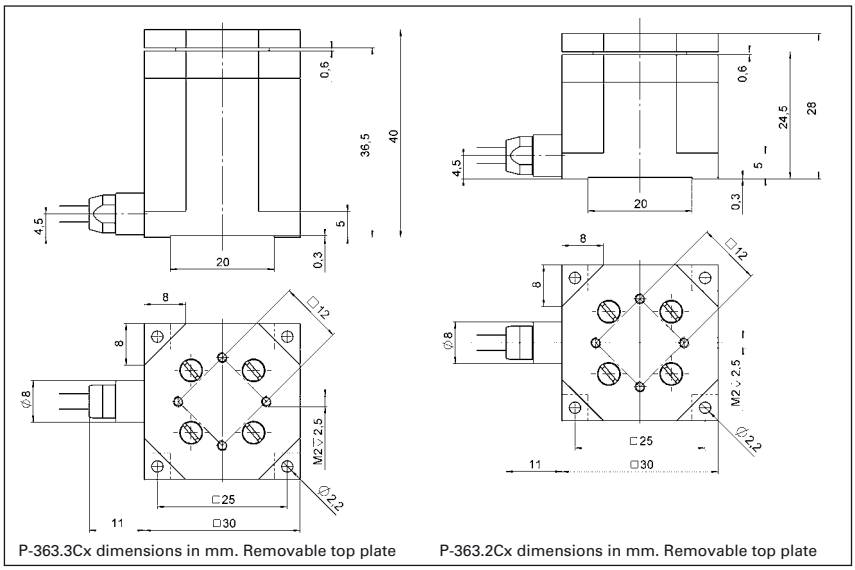
Rugged Design

In spite of its ability to move and position on an atomic scale, the PicoCube™ boasts a rugged design for real-world applications. For extra-high stability and reduced mass, the body is precision machined from heat-treated and stress-relieved titanium. The sophisticated frictionless design also ensures that the (moving) top plate protects the internal actuator/sensor unit from contamination.

Controller

For dynamic scanning opera - tion the E-725.3CM high-power digital controller offers advanced linearization algorithms for sub-nanometer precision (see p. 2-126).

Alternatively the analog E-536 PicoCube™ controller (see p. 2-134) comes in different versions optimized for resolution or power . An optional E-517 24-bit interface module is also available (see p. 2-156).



P-363.3Cx dimensions in mm. Removable top plate

P-363.2Cx dimensions in mm. Removable top plate

Technical Data

Model	P-363.3CD	P-363.2CD	Units
Active axes	X, Y, Z	X, Y	
Motion and positioning			
Integrated sensor	Capacitive	Capacitive	
Open-loop travel X, Y, -250 to +250 V	±3	±3	µm
Open-loop travel, -250 to +250 V	±2.7	–	µm
Closed-loop travel X, Y	±2.5	±2.5	µm
Closed-loop travel	±2.5	–	µm
Open-loop resolution	0.03*	0.03*	nm
Closed-loop resolution	0.1	0.1nm	
Linearity	0.05	0.05	%
Repeatability	1**	1**	nm
Pitch / yaw in X, Y	0.5	0.5	µrad
Runout X, Y (Z motion)	0.2	–	µrad
Straightness in X, Y	3	3	nm
Flatness in X, Y	<10	<10	nm
Crosstalk X, Y (Z motion)	5	–	nm
Mechanical properties			
Unloaded resonant frequency in X, Y	3.1	4.2	kHz
Unloaded resonant frequency (Z)	9.8	–	kHz
Resonant frequency in X, Y	1.5 (20 g)	2.1 (20 g)	kHz
Load capacity	10	10	N
Ceramic type	PICA™, PICA™ Shear	PICA™ Shear	
Miscellaneous			
Operating temperature range	-20 to 80	-20 to 80	°C
Material	Titanium	Titanium	
Dimensions	30 x 30 x 40	30 x 30 x 28	mm
Mass	225	190	g
Cable length	1.5	1.5	m
Sensor / voltage connection***	Sub-D connector PicoCube™	Sub-D connector PicoCube™	
Recommended controller	E-536 PicoCube™ Controller	E-536 PicoCube™ Controller	

Resolution of PI Piezo Nanopositioners is not limited by friction or stiction. V alue given is noise equivalent motion with E-536 controller (p. 2-134)

*With E-536.3xH Controller

**for 10% travel in Z; 50 nm for 100 % travel in Z

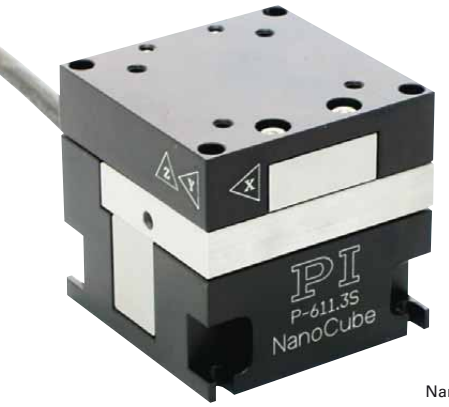
***P-363.xCL versions with LEMO connectors

System properties

System configuration	P-363.3CD (Z-axis) with 20 g load and E-536 servo controller
Settling time	(10 % step width) 1 ms

P-611.3 NanoCube® XYZ Piezo Stage

Low Cost Multi-Axis Piezo System for Nanopositioning and Fiber Alignment



NanoCube® XYZ-nanopositioning system, 100 x 100 x 100 µm closed-loop travel range, resolution 1 nm

- **Up to 120 x 120 x 120 µm Travel Range**
- **Very Compact: 44 x 44 x 44 mm**
- **Resolution to 0.2 nm, Rapid Response**
- **Frictionless, High-Precision Flexure Guiding System**
- **Outstanding Lifetime Due to PICMA® Piezo Actuators**
- **Fast Multi-Axis Scanning**
- **Version with Integrated Fiber Adapter Interface**
- **Cost-Effective Mechanics/Electronics System Configurations**

The P-611 NanoCube® piezo stage is a versatile, multi-axis piezo-nanopositioning system. Its 100 x 100 x 100 µm positioning and scanning range comes in an extremely compact package of only 44 x 44 x 44 mm. Equipped with a stiff, zero-stiction, zero-friction guiding system, this NanoCube® provides motion with ultra-high resolution and settling times of only a few milliseconds. The minimal moved masses and the stiff piezo drive make it ideal for high-throughput applications such as fiber alignment where it enables significantliy faster device characterization than achievable with conventional motorized drives.

Application Examples

- Photonics / integrated optics
- Micromanipulation
- Biotechnology
- Semiconductor testing
- Fiber positioning

Closed-Loop and Open-Loop Versions

High-resolution, fast-responding, strain gauge sensors (SGS) are applied to appropriate locations on the drive train and provide a high-bandwidth, nanometer-precision position feedback signal to the controller. The sensors are connected in a full-bridge configuration to eliminate thermal drift, and assure optimal position stability in the nanometer range.

The open-loop models are ideal for applications where fast response and very high resolution are essential, but absolute positioning is not important, e.g. in tracking or fiber positioning. They can also be used when the position is controlled by an external linear position sensor such as an interferometer, a PSD (position sensitive diode), CCD chip / image processing system, or the eyes and hands of an operator.

Versatility & Combination with Motorized Stages

The P-611 family of piezo stages comprises a variety of single- and multi-axis versions (X, XY, Z, XZ and XYZ) that can be easily combined with a number of very compact manual or motorized micropositioning systems to form coarse/fine positioners with longer travel ranges (see p. 2-20, p. 2-36 and p. 2-50). For fiber positioning tasks, several fiber, waveguide and optics adapters are available for mounting on the NanoCube® P-611.3SF (e.g. for combination with the F-206.S nanoalignment system see p. 4-12).

High Reliability and Long Lifetime

The compact P-611 systems are equipped with preloaded PICMA® high-performance piezo actuators which are integrated into a sophisticated, FEA-modeled, flexure guiding system. The PICMA® actuators feature cofired ceramic encapsulation and thus offer better performance and reliability than conventional piezo actuators. Actuators, guidance and sensors are maintenance-free and not subject to wear, and thus offer an extraordinary reliability.

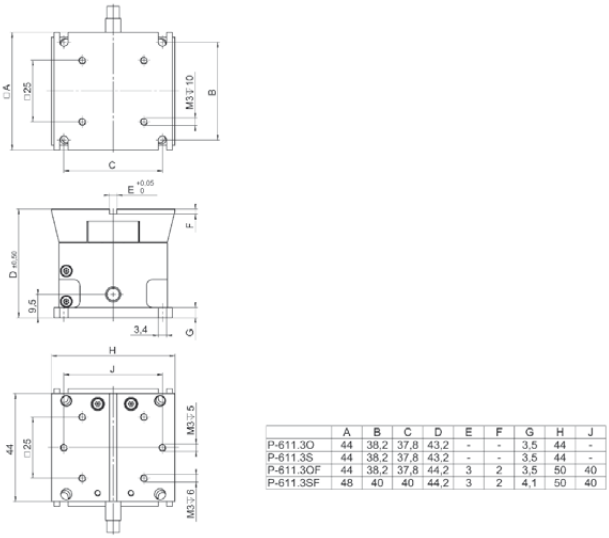
Ordering Information

P-611.3S
NanoCube® XYZ Nanopositioning System, 100 x 100 x 100 µm, Strain Gauge Sensors

P-611.30
NanoCube® XYZ Nanopositioning System, 100 x 100 x 100 µm, Open-Loop

P-611.3SF
NanoCube® XYZ Nanopositioning System, 100 x 100 x 100 µm, Strain Gauge Sensors, Fiber Adapter Interface

P-611.30F
NanoCube® XYZ Nanopositioning System, 100 x 100 x 100 µm, Open-Loop, Fiber Adapter Interface



	A	B	C	D	E	F	G	H	J
P-611.3O	44	38,2	37,8	43,2	-	-	3,5	44	-
P-611.3S	44	38,2	37,8	43,2	-	-	3,5	44	-
P-611.3OF	44	38,2	37,8	44,2	3	2	3,5	50	40
P-611.3SF	48	40	40	44,2	3	2	4,1	50	40

P-611.3 dimensions in mm

Combination of P-611.3SF NanoCube® XYZ Nanopositioning System, 100 x 100 x 100 µm and M-111 XYZ MicroPositioner 15 x 15 x 15 mm

Technical Data

Model	P-611.3S P-611.3SF	P-611.3O P-611.3OF	Units	Tolerance
Active axes	X, Y, Z	X, Y, Z		
Motion and positioning				
Integrated sensor	SGS			
Open-loop travel, -20 to +120 V	120 / axis	120 / axis	µm	min. (+20 %/0 %)
Closed-loop travel	100 / axis	–	µm	
Open-loop resolution	0.2	0.2	nm	typ.
Closed-loop resolution	1	–	nm	typ.
Linearity	0.1	–	%	typ.
Repeatability	<10	–	nm	typ.
Pitch in X,Y	±5	±5	µrad	typ.
Runout θ_X (Z motion)	±10	±10	µrad	typ.
Yaw in X	±20	±20	µrad	typ.
Yaw in Y	±10	±10	µrad	typ.
Runout θ_Y (Z motion)	±10	±10	µrad	typ.
Mechanical properties				
Stiffness	0.3	0.3	N/µm	±20 %
Unloaded resonant frequency X / Y / Z	350 / 220 / 250	350 / 220 / 250	Hz	±20 %
Resonant frequency @ 30 g X / Y / Z	270 / 185 / 230	270 / 185 / 230	Hz	±20 %
Resonant frequency @ 100 g X / Y / Z	180 / 135 / 200	180 / 135 / 200	Hz	±20 %
Push/pull force capacity in motion direction	+15 / -10	+15 / -10	N	Max.
Load capacity	15	15	N	Max.
Drive properties				
ceramic type	PICMA® P-885	PICMA® P-885		
Electrical capacitance	1.5	1.5	µF	±20 %
Dynamic operating current coefficient	1.9	1.9	µA/(Hz • µm)	±20 %
Miscellaneous				
Operating temperature range	-20 to 80	-20 to 80	°C	
Material	Aluminum, steel	Aluminum, steel		
Dimensions	44 x 44 x 43.2 SF-version: 44 x 50 x 44.2	44 x 44 x 43.2 OF-version: 44 x 50 x 44.2	mm	
Mass	0.32	0.32	kg	±5 %
Cable length	1.5	1.5	m	±10 mm
Sensor connector	Sub-D	–		
Voltage connection	Sub-D	Sub-D		
Recommended controller / amplifier	E-664 Nanocube® Controller (p. 2-137)	3 x E-610.00F OEM amplifier modules (p. 2-110); E-663 3-channel amplifier, bench-top (p. 2-136)		

Resolution of PI Piezo Nanopositioners is not limited by friction or stiction. Value given is noise equivalent motion with E-503 amplifier (p. 2-146)
Dynamic Operating Current Coefficient in µA per Hz and µm. Example: Sinusoidal scan of 50 µm at 10 Hz requires approximately 0.8 mA drive current.
Adapter cable with LEMO connectors for sensor and operating voltage available.

P-615 NanoCube® XYZ Piezo System

Long-Travel Multi-Axis Piezo Stage for Precision Alignment Applications

P-615NanoCube® XYZ Nanopositioning System provides up to 420 x 420 x 300 µm travel range

- **Up to 420 x 420 x 300 µm Travel Range**
- **Resolution 1 nm**
- **Parallel-Kinematics / Metrology for Enhanced Responsiveness / Multi-Axis Precision**
- **Clear Aperture of 10 mm Ø, Ideal for Alignment and Photonics Packaging Applications**
- **Outstanding Lifetime Due to PICMA® Piezo Actuators**
- **Open- & Closed-Loop Versions**
- **Vacuum-Compatible Versions to 10^{-9} hPa**
- **Frictionless, High-Precision Flexure Guiding System**

The P-615 NanoCube® is a multi-axis piezo nanopositioning and alignment system. Its 420 x 420 x 300 µm, XYZ positioning and scanning range comes in a compact package. Equipped with a zero-stiction, zero-friction guidance system, this NanoCube® provides motion with ultra-high resolution and settling times of only a few milliseconds.

Fiber Positioning

The P-615 NanoCube® is equipped with a fiber adapter interface similar to the P-611.3SF and accommodates all F-603-series fiber holders and accessories. Fiber optics handling is facilitated by the clear aperture.

Application Examples

- Micromanipulation
- Biotechnology
- Semiconductor testing
- Photonics / integrated optics

Double Stiffness for Fast Response

The P-615's unique flexure design has double the stiffness in the vertical axis than in X and Y, providing faster response and higher operating frequencies under load. For example, the settling time to reach a commanded position with 1% accuracy is only 15 ms in the Z-axis with 100 g load (as opposed to 10 ms without load).

Open-Loop and Closed-Loop Operation

The open-loop basic model P-615.30L is ideal for applications where fast response and very high resolution are essential but specifying or reporting absolute position values is either not required or is handled by external sensors, e. g. in tracking or fiber positioning tasks. In open-loop mode, the piezo displacement is roughly proportional to the applied voltage (see p. 2-184).

Capacitive Sensors for Highest Accuracy

The P-615.3C models are equipped with high-accuracy, capacitive position sensors. PI's proprietary capacitive sensors measure position directly and without physical contact. They are free of friction and hysteresis, a fact which, in combination with the positioning resolution of well under 1 nm, makes it possible to achieve very high levels of linearity. A further advantage of direct metrology with capacitive sensors is the high phase fidelity and the high bandwidth of up to 10 kHz.

Active and Passive Guidance for Nanometer Flatness and Straightness

Wire-cut flexures optimized with Finite Element Analysis (FEA) are used to guide the stage. The FEA techniques give the design the highest possible stiffness and minimize linear and angular runout. Further enhancement is achieved by active trajectory control: multi-axis nanopositioning systems equipped with parallel metrology are able to measure platform position in all degrees of freedom against a common, fixed reference. In such systems, undesirable motion from one actuator in the direction of another (cross-talk) is detected immediately and actively compensated by the servo-loops. This can keep deviation from a trajectory to under a few nanometers, even in dynamic operation.

Ceramic Insulated Piezo Actuators Provide Long Lifetime

Highest possible reliability is assured by the use of award-winning PICMA® multilayer piezo actuators. PICMA® actuators are the only actuators on the market with ceramic-only insulation, which makes them resistant to ambient humidity and leakage-current failures. They are thus far superior to conventional actuators in reliability and lifetime.

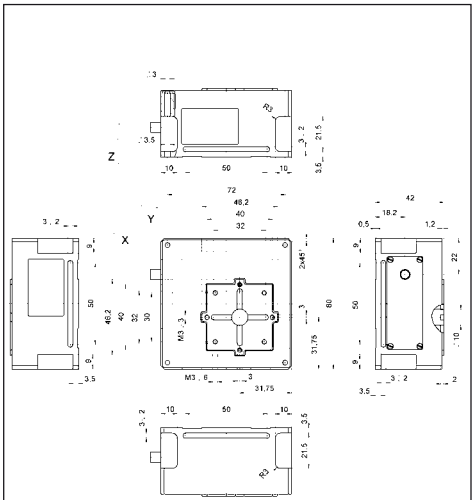
Ordering Information

P-615.3CD
NanoCube® XYZ Nanopositioning System with Long Travel Range, 350 x 350 x 250 µm, Parallel Metrology, Capacitive Sensors, Sub-D Connector

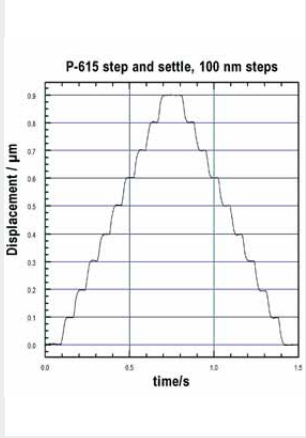
P-615.3CL
NanoCube® XYZ Nanopositioning System with Long Travel Range, 350 x 350 x 250 µm, Parallel Metrology, Capacitive Sensors, LEMO Connector

P-615.30L
NanoCube® XYZ Nanopositioning System with Long Travel Range, 420 x 420 x 300 µm, Parallel Metrology, Open-Loop, LEMO Connector

P-615.3UD
NanoCube® XYZ Nanopositioning System with Long Travel Range, 350 x 350 x 250 µm, Parallel Metrology, Capacitive Sensors, Sub-D Connector, Vacuum Compatible to 10^{-9} hPa



P-615 dimensions in mm.
The clear aperture has a diameter of 10 mm.



P-615, X-axis with 100 g load performing 100 nm steps in rapid sequence without overshoot. Settling time for the Z-axis to reach a commanded position with 1 % accuracy is only 15 ms.

P-615 with optional fiber holder F-603.22

Technical Data

Model	P-615.3CD / P-615.3CL	P-615.30L	Units	Tolerance
Active axes	X, Y, Z	X, Y, Z		
Motion and positioning				
Integrated sensor	Capacitive	–		
Open-loop travel in X/Y/Z, -20 to +120 V	420 / 420 / 300	420 / 420 / 300	µm	min. (+20 %/-0 %)
Closed-loop travel X/Y/Z	350 / 350 / 250	–	µm	
Open-loop resolution X/Y/Z	0.5	0.5	nm	typ.
Closed-loop resolution X/Y/Z	1	–	nm	typ.
Linearity X/Y/Z	0.02	–	%	typ.
Repeatability in X, Y, Z	±7.5 / ±7.5 / ±5	–	nm	typ.
Pitch in X,Y	100	100	µrad	typ.
Yaw in X, Y	50	50	µrad	typ.
Runout θ_X, θ_Y (Z motion)	10	10	µrad	typ.
Mechanical properties				
Stiffness X / Y / Z	0.13 / 0.13 / 0.35	0.13 / 0.13 / 0.35	N/µm	±20 %
Unloaded resonant frequency in X / Y / Z	210 / 210 / 250	210 / 210 / 250	Hz	±20 %
Resonant frequency @ 100 g in X / Y / Z	125 / 125 / 200	125 / 125 / 200	Hz	±20 %
Push/pull force capacity in motion direction	20 / 10	20 / 10	N	Max.
Load capacity	20	20	N	Max.
Drive properties				
Ceramic type	PICMA® P-885	PICMA® P-885		
Electrical capacitance in X / Y / Z	3.7 / 3.7 / 6.2	3.7 / 3.7 / 6.2	µF	±20 %
Dynamic operating current coefficient (DOCC) in X / Y / Z	1.3 / 1.3 / 3.1	1.3 / 1.3 / 3.1	µA/(Hz·µm)	±20 %
Miscellaneous				
Operating temperature range	-20 to 80	-20 to 80	°C	
Material	Aluminum	Aluminum		
Mass	0.58	0.57	kg	±5 %
Cable length	1.5	1.5	m	±10 mm
Sensor / voltage connection	Sub-D special (CD-version); (no LEMO (CL-version)	LEMO sensor)		

Resolution of PI Piezo Nanopositioners is not limited by friction or stiction. Value given is noise equivalent motion with E-503 amplifier (p. 2-146).

Recommended controller
Multi-channel digital controllers: E-710 bench-top (p. 2-128), E-712 modular (p. 2-140), E-725 high-power (p. 2-126), E-761 PCI board (p. 2-130)
Multi-channel:
E-500 modular piezo controller system (p. 2-142) with E-509 servo-controller (p. 2-152) (optional) and as amplifier either E-503 (three channels) (p. 2-146) or E-505 (1 per axis, high-power, p. 2-147) modules P-615.30L (p. 2-68): E-610 controller / amplifier (p. 2-110) (1 per axis)

PIHera ® XY Stage and XYZ Stage with Piezo Flexure Drive

High-Precision Nanopositioner Family–Compact and Long Travel Ranges

PIHera® XY nanopositioning systems provide travel ranges from 50 x 50 µm to 1800 x 1800 µm

- **Travel Ranges 50 to 1800 µm**
- **High-Precision, Cost-Efficient**
- **Resolution to 0.1 nm**
- **Frictionless, High-Precision Flexure Guiding System**
- **0,02 % Positioning Accuracy**
- **Outstanding Lifetime Due to PICMA® Piezo Actuators**
- **X-, XY-, Z- and XYZ-Versions**
- **Vacuum-Compatible Versions Available**

Two-axis (XY) PIHera® systems are piezo-nanopositioning stages featuring travel ranges from 50 to 1800 µm. Despite the increased travel ranges, the units are extremely compact and provide rapid response and high guiding precision. This, and the long travel range is achieved with a friction-free and extremely stiff flexure system sub-nanometer resolution. The PIHera® piezo nanopositioning series also includes Z and X stages (see p. 2-22 and p. 2-40).

Application Examples

- Interferometry
- Microscopy
- Nanopositioning
- Biotechnology
- Quality assurance testing
- Semiconductor technology

Nanometer Precision in Milliseconds

One of the advantages of PIHera® stages over motor-driven positioning stages is the rapid response to input changes and the fast and precise settling behavior. The P-622.1CD, for example, can settle to an accuracy of 10 nm in only 30 msec (other PI stages provide even faster response)!

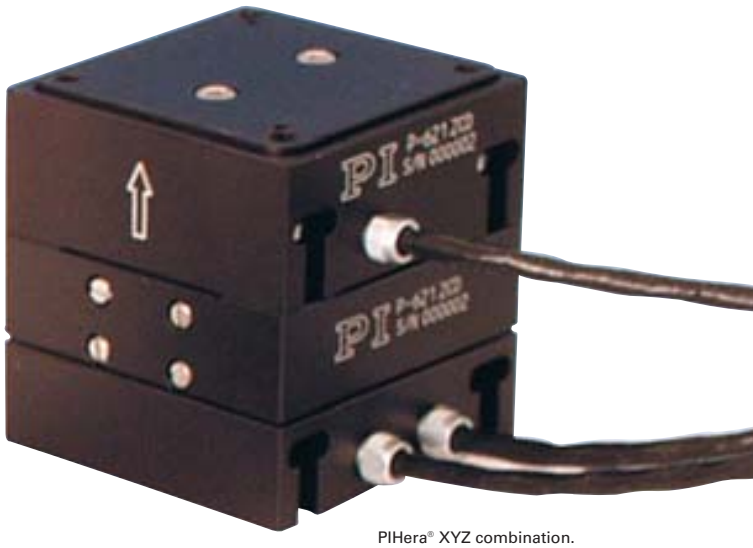
Superior Accuracy With Direct-Metrology Capacitive Sensors

A choice of tasks such as optical path adjustment in interferometry, sample positioning in microscopy, precision alignment or optical tracking require the relatively long scanning ranges and nanometer precision offered by PIHera® nanopositioning stages.

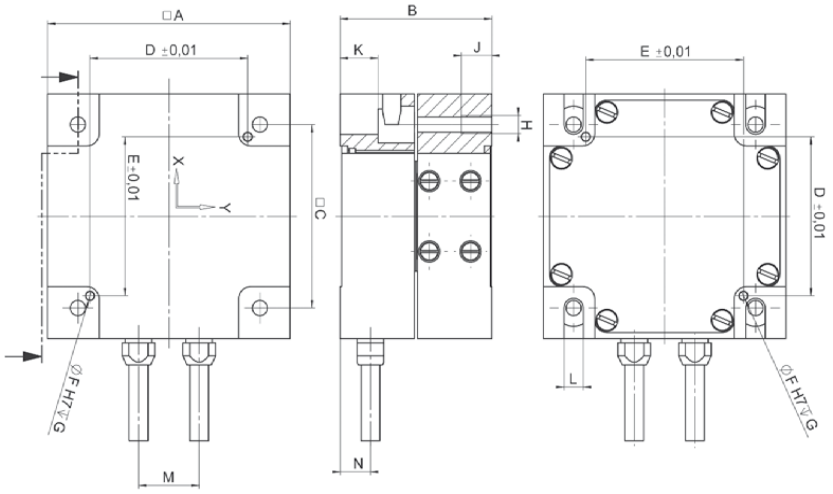
PI's proprietary capacitive sensors measure position directly and without physical contact. They are free of friction and hysteresis, a fact which, in combination with the positioning resolution of well under 1 nm, makes it possible to achieve very high levels of linearity. A further advantage of direct metrology with capacitive sensors is the high phase fidelity and the high bandwidth of up to 10 kHz.

Designed for Precision

High stiffness is achieved with the FEA-optimized design of the frictionless flexure elements, which assure excellent guiding accuracy and dynamics. A straightness and flatness in the nanometer range is achieved.



PIHera® XYZ combination.



	A	B	C	D	E	⌀F	G	H	J	K	L	M	N
P-620.2CD /20L	30	21,5	24	24	19	1,01	1,5	M2	3,5	5,1	2,2	9	6
P-621.2CD / 20L	40	25	30	26	26	1,51	2,5	M3	5	6,25	3,2	10	5
P-622.2CD / 20L	50	25	40	35	35	1,51	2,5	M3	5	6,25	3,2	11	5
P-625.2CD / 20L	60	25	50	46	46	1,51	2,5	M3	6	6,25	3,2	11	5
P-628.2CD / 20L	80	30	70	66	66	1,51	2,5	M3	6	6,75	3,2	11	5
P-629.2CD / 20L	100	40	90	82	82	2,01	3,5	M4	7	9,75	4,3	16	7,5

P-62x.2CD/.2CL/.20L dimensions in mm

Technical Data

Model	P-620.2CD/ P-620.2CL	P-621.2CD/ P-621.2CL	P-622.2CD/ P-622.2CL	P-625.2CD/ P-625.2CL	P-628.2CD/ P-628.2CL	P-629.2CD P-629.2CL	P-62x.20L open-loop versions	Units	Tolerance
Active axes	X, Y	X, Y	X, Y	X, Y	X, Y	X, Y	X, Y		
Motion and positioning									
Integrated sensor	Capacitive	Capacitive	Capacitive	Capacitive	Capacitive	Capacitive	–		
Open-loop travel X, Y, -20 to +120 V	60	120	300	600	950	1800	as P-62x.2CD	µm	min. (+20 %/-0 %)
Closed-loop travel	50	100	250	500	800	1500	–	µm	
Open-loop resolution	0.1	0.2	0.4	0.5	0.5	2	as P-62x.2CD	nm	typ.
Closed-loop resolution	0.2	0.4	0.7	1.4	3.5	3.5	–	nm	typ.
Linearity	0.02	0.02	0.02	0.03	0.03	0.03	–	%	typ.
Repeatability	±2	±2	±2	±5	±10	±14	as P-62x.2CD	nm	typ.
Pitch / yaw	±3	±3	±3	±3	±20	±30	as P-62x.2CD	µrad	typ.
Mechanical properties									
Stiffness	0.22	0.25	0.2	0.1	0.05	0.1	as P-62x.2CD	N/µm	±20 %
Unloaded resonant frequency in X,	575	420	225	135	75	60	as P-62x.2CD	Hz	±20 %
Unloaded resonant frequency in Y	800	535	300	195	105	100	as P-62x.2CD	Hz	±20 %
Resonant frequency in X @ 50 g	270	285	180	120	60	55	as P-62x.2CD	Hz	±20 %
Resonant frequency in Y @ 50 g	395	365	215	150	85	85	as P-62x.2CD	Hz	±20 %
Resonant frequency in X @ 100 g	285	220	160	105	55	50	as P-62x.2CD	Hz	±20 %
Resonant frequency in Y @ 100 g	300	285	175	125	75	80	as P-62x.2CD	Hz	±20 %
Push/pull force capacity in motion direction	10 / 5	10 / 8	10 / 8	10 / 8	10 / 8	10 / 8	as P-62x.2CD	N	Max.
Load capacity	10	10	10	10	10	10	as P-62x.2CD	N	Max.
Lateral Force	10	10	10	10	10	10	as P-62x.2CD	N	Max.
Drive properties									
Ceramic type	PICMA® P-883	PICMA® P-885	PICMA® P-885	PICMA® P-885	PICMA® P-887	PICMA® P-888	as P-62x.2CD		
Electrical Capacitance	0.35	1.5	3.1	6.2	19	52	as P-62x.2CD	µF	±20 %
Dynamic operating current coefficient	0.9	1.9	1.9	1.6	3	4.3	as P-62x.2CD	µA/(Hz•µm)	±20 %
Miscellaneous									
Operating temperature range	-20 to 80	-20 to 80	-20 to 80	-20 to 80	-20 to 80	-20 to 80	-20 to 150	°C	
Material	Aluminum	Aluminum	Aluminum	Aluminum	Aluminum	Aluminum	Aluminum		
Mass	0.195	0.295	0.348	0.43	0.7	1.37	as P-62x.2CD	kg	±5 %
Cable length	1.5	1.5	1.5	1.5	1.5	1.5	1.5	m	±10 mm
Sensor / voltage connection	CD version: 2x Sub-D special CL version: LEMO	CD version: 2x Sub-D special CL version: LEMO	CD version: 2x Sub-D special CL version: LEMO	CD version: 2x Sub-D special CL version: LEMO	CD version: 2x Sub-D special CL version: LEMO	CD version: 2x Sub-D special CL version: LEMO	2x LEMO (no sensor)		

Lower axis: X; upper axis: Y.
Resolution of PI Piezo Nanopositioners is not limited by friction or stiction. The value given is noise equivalent motion with E-710 controller (p. 2-128)
Recommended controller
CD version: E-610 servo controller / amplifier (p. 2-110), E-625 servo controller, bench-top (p. 2-114), E-665 powerful servo controller, bench-top (p. 2-116)
Multi-channel digital controllers: E-710 bench-top (p. 2-128), E-712 modular (p. 2-140), E-725 high-power (p. 2-126), E-761 PCI board (p. 2-140)
CL version: E-500 modular piezo controller system (p. 2-142) with E-505 amplifier module (1 per axis, high power) (p. 2-147) and E-509 controller (p. 2-152)
Open-loop versions: E-500 modular piezo controller system (p. 2-142) with E-505 amplifier module (1 per axis, high power) (p. 2-147)

Program Overview

- Piezo Ceramic Actuators & Motors
- Piezo Nanopositioning Systems and Scanners
- Active Optics / Tip-Tilt Platforms
- Capacitive Nanometrology Sensors
- Piezo Electronics: Amplifiers and Controllers
- Hexapod 6-Axis Positioners / Robots
- Micropositioning Stages & Actuators
- Photonics Alignment Systems, Solutions for Telecommunications
- Motor Controllers
- Ultrasonic Linear Motors

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